

SIDC46D170H

Fast switching diode chip in EMCON 3-Technology

FEATURES:

- 1700V EMCON 3 technology 200 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules



Applications:

resonant applications, drives

Chip Type	V _R	I _F	Die Size	Package	Ordering Code
SIDC46D170H	1700V	75A	6.8 x 6.8 mm ²	sawn on foil	Q67050-A4175- A001

MECHANICAL PARAMETER:

Raster size	6.8 x 6.8				
Area total / active	46.24 / 34.04	mm ²			
Anode pad size	4.78 x 4.78				
Thickness	200	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	304 pcs				
Passivation frontside	Photoimide				
Anode metallization	3200 nm Al Si Cu				
Cathode metallization	Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	ie bond electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ink Dot Size Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				

Edited by INFINEON Technologies AI DP PSD CLS, L 4471A, Edition 2, 2.11.2004



SIDC46D170H

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}		1700	V
Continuous forward current limited by T_{jmax}	I _F		75	
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$	430	А
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		150	
Operating junction and storage temperature	$T_{\rm j}$, $T_{\rm stg}$		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
i didilictei	- Cyllibol	Conditions		min.	Тур.	max.	
Reverse leakage current	I_{R}	V _R =1700V	<i>T_j</i> =25°C			27	μΑ
Cathode-Anode breakdown Voltage	V _{Br}	I _R =0.25mA	<i>T_j</i> =25°C	1700			V
Forward voltage drop	V _F	I _F =75A	<i>T_j</i> =25°C		1.8		V

Dynamic Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified, tested at component

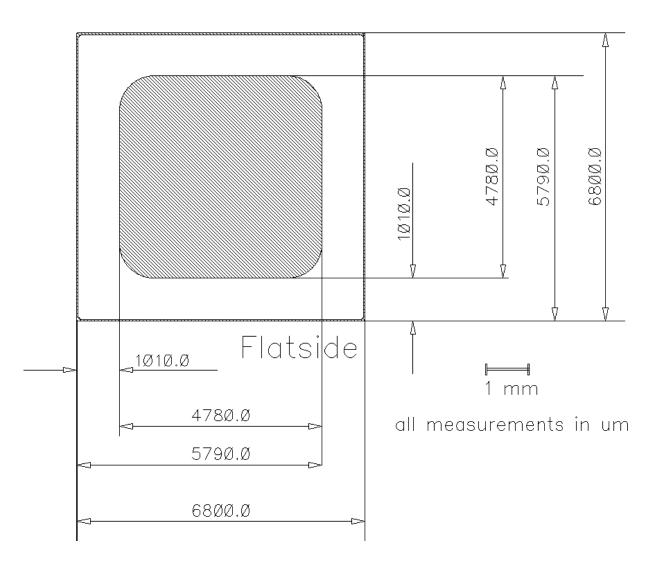
Parameter	Symbol	Conditions		Value			Unit
rarameter	Symbol			min.	Тур.	max.	Oiiit
Peak recovery current	I _{RRM1}	I _F =75A	$T_j = 25$ °C		93		Α
	I _{RRM2}	$ \begin{array}{c} - di/dt = 920 \text{A/ms} \\ V_R = 900 \text{V} \end{array} $	$T_j = 125 ^{\circ}\text{C}$		100		
Reverse recovery charge	Q _{rr1}	I _F =75A di/dt=920A/ m s	T _j =25°C		20.0		μC
	Q _{rr2}	$V_R = 900V$	$T_j = 125$ °C		31.7		٦μ٥
Reverse recovery energy	E _{rec 1}	I _F =75A	$T_{\rm j}$ = 25 ° C		10.0		I
	E _{rec2}	$di/dt=920 A/ms$ $V_R=900 V$	$T_j = 125$ °C		18.3		mJ





CHIP DRAWING:

L447A1





SIDC46D170H

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	INFINEON TECHNOLOGIES / EUPEC	tbd		
Description:				
AQL 0,65 for visual inspection according to	failure catalog			
Electrostatic Discharge Sensitive Device according to MIL-STD 883				
Test-Normen Villach/Prüffeld				

Published by Infineon Technologies AG Bereich Kommunikation St.-Martin-Strasse 53 D-81541 München © Infineon Technologies AG 2000 All Rights Reserved.

Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

Edited by INFINEON Technologies AI DP PSD CLS, L 4471A, Edition 2, 2.11.2004